

EMC TEST REPORT

According to

EN 60601-1-2: 2007 (EN 55011: 2009+ A1: 2010) EN 60601-1-2: 2007

EN 61000-3-2: 2014 IEC 61000-4-2: 2008

EN 61000-3-3: 2013 IEC 61000-4-3: 2006+A1:2007+A2:2010

> IEC 61000-4-4: 2012 IEC 61000-4-5: 2005 IEC 61000-4-6: 2008 IEC 61000-4-8: 2009

IEC 61000-4-11: 2004

Applicant GlobTek, Inc.

Address 186 Veterans Dr. Northvale, NJ 07647, USA

: MEDICIAL POWER SUPPLY Equipment

GT*41078-*05-USB (The 1st "*" part can be

'M' or '-' or 'H' for market identification and not

related to safety. The 2nd "*" part denotes the Model No.

rated output wattage designation, which can

be "01" to "06", with interval of 1.)

I HEREBY CERTIFY THAT:

The sample was received on Jan. 05, 2016 and the testing was carried out on Jan. 16, 2016 at Cerpass Technology Corp. The test result refers exclusively to the test presented test model / sample. Without written approval of Cerpass Technology Corp., the test report shall not be reproduced except in full.

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EMC TEST REPORT

Issued by:

Cerpass Technology (Suzhou) Co.,Ltd No.66, Tangzhuang Road, Suzhou Industrial Park, Jiangsu 215006, China Tel:86-512-6917-5888

Fax:86-512-6917-5666

The test record, data evaluation & Equipment Under Test configurations represented herein are true and accurate accounts of the measurements of the samples EMC characteristics under the conditions specified in this report.

The above equipment was tested by Cerpass Technology Corp. for compliance with the requirements of technical standards specified above under the EMC Directive 2004/108/EC & 93/42/EEC. The results of testing in this report apply only to the product/system, which was tested. Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties

Approved by:

Miro Chueh

EMC/RF B.U. Manager

Laboratory Accreditation:

Cerpass Technology Corporation Test Laboratory

200954-0 **NVLAP LAB Code:** 1439 **TAF LAB Code:**

Cerpass Technology(SuZhou) Co., Ltd.

NVLAP LAB Code:	200814-0
CNAS LAB Code:	L5515

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History of this test report

■ ORIGINAL.

 $\hfill\square$ Additional attachment as following record:

Report No	Version	Date	Description
SECM1601003	Rev 01	Jan 13, 2016	Initial Issue

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CE

Report No.: SECM1601003

1. Summary of Test Procedure and Test Results

EMISSION [EN 60601-1-2 : 2007 (EN 55011: 2009+ A1: 2010)]					
Standard	Item	Result	Remarks		
	Conducted (Power Port)		Meet Class B Limit Minimum passing margin(AV) is -8.81 dB at 0.4980 MHz		
EN 60601-1-2 : 2007 (EN 55011: 2009+ A1: 2010)	Conducted (Telecom port)	N/A	N/A		
(EN 55011, 2009+ A1, 2010)	Radiated	PASS	Meets Class B Limit Minimum passing margin(Peak) is -7.32 dB at 30.0000 MHz		
EN 61000-3-2: 2014	Harmonic current emissions	PASS	Meet Class D Limit		
EN61000-3-3: 2013	Voltage fluctuations & flicker	PASS	Meets the requirements		

IMMUNITY [EN 60601-1-2 : 2007]					
Standard	Item	Result	Remarks		
IEC 61000-4-2: 2008	ESD	PASS	Meets the requirements of Performance Criterion A		
IEC 61000-4-3: 2006+A1:2007+A2:2010	RS	PASS	Meets the requirements of Performance Criterion A		
IEC 61000-4-4: 2004+ A1:2010	EFT	PASS	Meets the requirements of Performance Criterion A		
IEC 61000-4-5:2005	Surge	PASS	Meets the requirements of Performance Criterion A		
IEC 61000-4-6:2008	CS	PASS	Meets the requirements of Performance Criterion A		
IEC 61000-4-8:2009	PFMF	PASS	Meets the requirements of Performance Criterion A		
IEC 61000-4-11:2004	Voltage dips & voltage variations	PASS	Meets the requirements of Voltage Dips: 1) >95% reduction Performance Criterion B 2) 30% reduction Performance Criterion B 3) 60% reduction Performance Criterion B Voltage Interruptions: 1) >95% reduction Performance Criterion C		

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2. Immunity Testing Performance Criteria Definition

Criteria A:	The apparatus shell continues to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance. If the manufacturer does not specify the minimum performance level or the permissible performance loss, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
	After test, the apparatus shell continues to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomenon below a performance level specified by the manufacturer, when the apparatus is used as intended. The performance level may be replaced by a permissible loss of performance.
Criteria B:	During the test, degradation of performance is however allowed. However, no change of operating state if stored data is allowed to persist after the test. If the manufacturer does not specify the minimum performance level or the permissible performance loss, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
Criteria C:	Temporary loss of function is allowed, provided the functions is self-recoverable or can be restored by the operation of controls by the user in accordance with the manufacturer instructions.
	Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

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3. Test Configuration of Equipment under Test

3.1. Factory

GlobTek (Suzhou) Co., Ltd

Building 4, No. 76, Jin Ling East Rd., Suzhou Industrial Park, Suzhou, JiangSu 215021, China

3.2. Feature of Equipment under Test

Product Name:	MEDICIAL POWER SUPPLY
Model Name:	GT*41078-*05-USB The 1st "*" part can be 'M' or '-' or 'H' for market identification and not related to safety. The 2nd "*" part denotes the rated output wattage designation, which can be "01" to "06", with interval of 1.
Remark:	GTM41078-0605-USB was selected as the test model and its data have been recorded in this report.
Input Rating:	100-240V,50Hz-60Hz,0.3A
Output Rating:	5V === 1.2A

Note: Please refer to user manual.

3.3. Test Manner

- a. During testing, the interface cables and equipment positions were varied according to Europe Standard EN 60601-1-2.
- b. The complete test system included Load, Meter and EUT for EMI test.

The pre-test modes

Test Mode 1: Full Load Test Mode 2: Half Load

The worse case was selected as the final test mode and record in the report

Test Mode 1: Full Load Test Mode 2: Half Load

3.4. Description of Support Unit

No	Device	Manufacturer	Model No.	Description
1	Load	N/A	N/A	N/A
2	Meter	FLUKE	N/A	N/A

Item	Cable	Quantity	Description
Α	USB Cable	1	Non-shielded, 0.3m
В	Meter Cable	2	Non-shielded, 1.2m

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3.5. General Information of Test

	1	
		Cerpass Technology Corporation Test Laboratory
		Address: No.10, Ln. 2, Lianfu St., Luzhu Dist., Taoyuan City
	Test Site	33848, Taiwan (R.O.C.)
		Tel:+886-3-3226-888
		Fax:+886-3-3226-881
		Address: No.68-1, Shihbachongsi, Shihding Township,
		New Taipei City 223, Taiwan, R.O.C.
		Tel: +886-2-2663-8582
	FCC	TW1079, TW1061,390316, 228391, 641184
	IC	4934B-1, 4934E-1, 4934E-2
		T-2205 for Telecommunication Test
	VCCI	C-4663 for Conducted emission test
	V 001	R-3428, R-4218 for Radiated emission test
		G-812, G-813 for radiated disturbance above 1GHz
		Cerpass Technology (Suzhou) Co.,Ltd
		Address: No.66,Tangzhuang Road, Suzhou Industrial Park,
	Test Site	Jiangsu 215006, China
		Tel: +86-512-6917-5888
		Fax: +86-512-6917-5666
	FCC	331395
	IC	7290A-1, 7290A-2
		T-1945 for Telecommunication Test
	VCCI	C-2919 for Conducted emission test
	VCCI	R-2670 for Radiated emission test
		G-227 for radiated disturbance above 1GHz
Frequency Range Investigated:		Conducted: from 150kHz to 30 MHz
		Radiation: from 30 MHz to 6000MHz
Test Distance :		The test distance of radiated emission below 1GHz from
		antenna to EUT is 10 M.
		The test distance of radiated emission above 1GHz from
		antenna to EUT is 3 M.

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3.6. Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

Measurement	Frequency	Uncertainty
Conducted emissions(LINE)	9KHz-30MHz	+/- 0.7738 dB
Conducted emissions(NEUTRAL)	9KHz-30MHz	+/- 0.7886 dB

Measurement	Polarity	Frequency	Uncertainty
	Н	30MHz ~ 200MHz	+/- 3.8909dB
Radiated emissions	11	200MHz ~1000MHz	+/- 3.6555dB
(below 1GHz)	V	30MHz ~ 200MHz	+/- 3.8948dB
	V	200MHz ~1000MHz	+/- 3.6538dB
Radiated emissions (above 1GHz)	Н	1000MHz ~18000MHz	+/- 3.8948 dB
		18000MHz ~40000MHz	+/-3.8844dB
	V	1000MHz ~18000MHz	+/- 3.8906dB
	V	18000MHz ~40000MHz	+/- 3.8744dB

Measurement	Uncertainty	
ESD—Rise time tr	10%	
ESD—Peak current lp	6%	
ESD—Current at 30 ns	6%	
ESD—Current at 60 ns	6%	
ESD- Charging voltage	1%	
RS above 1GHz	±2.37dB	
RS under 1GHz	±3.83dB	
EFT—Rise time tr	4%	
EFT—Peak current lp	4%	
EFT—Current	4%	
Surge—Rise time tr	4%	

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Surge—Peak current lp	4%		
Surge—Current	4%		
CS-CND	±0.80dB		
CS-Clamp	±1.06dB		

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Consistent with industry standard (e.g. CISPR 22: 2008, clause 11, Measurement Uncertainty) determining compliance with the limits shall be base on the results of the compliance measurement. Consequently the measure emissions being less than the maximum allowed emission result in this be a compliant test or passing test.

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4. Test of Conducted Emission

4.1. Test Limit

Conducted Emissions were measured from 150 kHz to 30 MHz with a bandwidth of 9 kHz and return leads of the EUT according to the methods defined in European Standard EN 55011. The EUT was placed on a nonmetallic stand in a shielded room 0.8 meters above the ground plane as shown in section 4.2. The interface cables and equipment positioning were varied within limits of reasonable applications to determine the position producing maximum conducted emissions.

Table 1 Conducted Emission Limits (dB(μ V)):

		Class A E	quipment				
Frequency range	Rated input power		Rated input power		Class B Equipment		
(MHz)	$of < 20kV\Delta$ of $> 20kV\Delta$						
(1711 12)	Quasi Peak	Avg.	Quasi Peak	Avg.	Quasi Peak	Avg.	
0.15 to 0.50	79	66	100	90	66~56	56~46	
0.50 to 5	73	60	86	76	56	46	
5 to 30	73	60	90~73	80~60	60	50	

Note 1: The limits decreasing linearly with logarithm of the frequency in the range 5 to 30MHz.

Note 2: The lower limits shall apply at the transition frequencies.

Table 2 - Limits of conducted common mode (asymmetric mode) disturbance at telecommunication ports in the frequency range 0.15 MHz to 30 MHz (dB(μ V)):

Frequency range (MHz)	Class A Equipment				Class B Equipment			
	Vol	oltage Current		Voltage		Current		
	Quasi Peak	Avg.	Quasi Peak	Avg.	Quasi Peak	Avg.	Quasi Peak	Avg.
0.15 to 0.5	97~ 87	84~74	53~43	40~30	84~74	74~64	40~30	30~20
0.5 to 5	87	74	43	30	74	64	30	20
5 to 30	87	74	43	30	74	64	30	20

Note 1: The limits decrease linearly with the logarithm of the frequency in the range 0.15 to 0.5 MHz.

Note 2: The current and voltage disturbance limits are derived for use with an impedance stabilization network (ISN) which presents a common mode (asymmetric mode) impedance of 150 Ω to the telecommunication under test (conversion factor is $20 \log_{10} 150/1 = 44dB$).

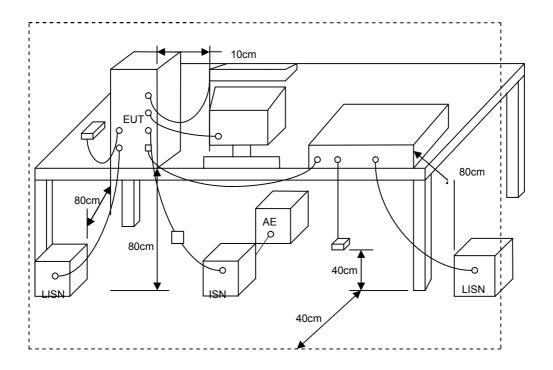
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4.2. Test Procedures

- a. The EUT was placed on a desk 0.8 meters height from the metal ground plane and 0.4 meter from the conducting wall of the shielding room and it was kept at least 0.8 meters from any other grounded conducting surface.
- b. Connect EUT to the power mains through a line impedance stabilization network (LISN).
- c. All the support units are connecting to the other LISN.
- d. The LISN provides 50 ohm coupling impedance for the measuring instrument.
- e. The CISPR states that a 50 ohm, 50 micro-Henry LISN should be used.
- f. Both sides of AC line were checked for maximum conducted interference.
- g. The frequency range from 150 kHz to 30 MHz was searched
- h. Set the test-receiver system to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.

4.3. Typical Test Setup



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4.4. Measurement Equipment

Instrument/Ancillary	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date.
Test Receiver	R&S	ESCI	100565	2015.03.29	2016.03.28
AMN	R&S	ESH2-Z5	100182	2015.09.06	2016.09.05
Two-Line V-Network	R&S	ENV216	100325	1	/
ISN	FCC	FCC-TLISN-T2-02	20379	2015.03.29	2016.03.28
ISN	FCC	FCC-TLISN-T4-02	20380	2015.03.29	2016.03.28
ISN	FCC	FCC-TLISN-T8-02	20381	2015.03.29	2016.03.28
ISN	TESEQ	ISN ST08	30175	2015.03.29	2016.03.28
Current Probe	R&S	EZ-17	100303	2015.03.29	2016.03.28
Passive Voltage Probe	R&S	ESH2-Z3	100026	2015.03.29	2016.03.28
Pulse Limiter	R&S	ESH3-Z2	100529	2015.03.29	2016.03.28
Temperature/ Humidity Meter	Zhicheng	ZC1-11	CEP-TH-004	2015.04.02	2016.04.01
EZ-EMC	Fala	Ver CT3A1	N/A	N/A	N/A

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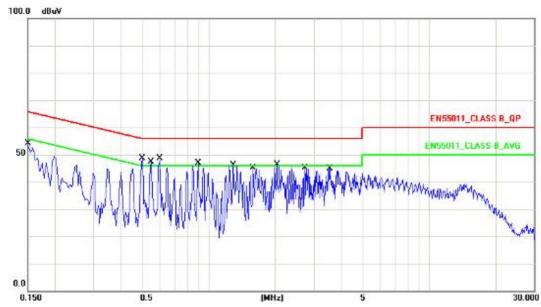
4.5. Test Result and Data

4.5.1 Conducted Emission for Power Port Test Data

Test Mode: Mode 1: Full Load

AC Power: AC 230V/50Hz Phase: LINE Temperature: 24°C Humidity: 52%

Pressure(mbar): 1002 Date: 2016/01/11



No.	Frequency (MHz)	Factor (dB)	Reading (dBuV)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector
1	0.1500	10.13	40.81	50.94	65.99	-15.05	QP
2	0.1500	10.13	30.15	40.28	55.99	-15.71	AVG
3	0.4980	10.16	35.68	45.84	56.03	-10.19	QP
4	0.4980	10.16	27.06	37.22	46.03	-8.81	AVG
5	0.5460	10.16	35.96	46.12	56.00	-9.88	QP
6	0.5460	10.16	27.26	37.42	46.00	-8.58	AVG
7	0.5980	10.16	35.11	45.27	56.00	-10.73	QP
8	0.5980	10.16	26.59	36.75	46.00	-9.25	AVG
9	0.8940	10.15	33.79	43.94	56.00	-12.06	QP
10	0.8940	10.15	24.27	34.42	46.00	-11.58	AVG
11	1.2900	10.16	35.19	45.35	56.00	-10.65	QP
12	1.2900	10.16	26.42	36.58	46.00	-9.42	AVG
13	1.5900	10.17	29.47	39.64	56.00	-16.36	QP
14	1.5900	10.17	19.80	29.97	46.00	-16.03	AVG
15	2.0340	10.17	34.24	44.41	56.00	-11.59	QP
16	2.0340	10.17	25.01	35.18	46.00	-10.82	AVG
17	2.7300	10.18	32.65	42.83	56.00	-13.17	QP
18	2.7300	10.18	24.09	34.27	46.00	-11.73	AVG
19	3.5300	10.20	25.67	35.87	56.00	-20.13	QP
20	3.5300	10.20	15.81	26.01	46.00	-19.99	AVG

Note: Measurement Level = Reading Level + Correct Factor

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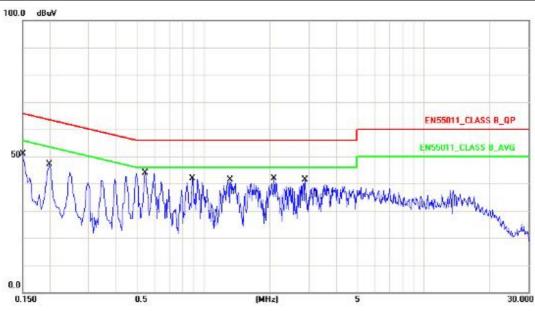


Test Mode: Mode 1: Full Load

AC Power: AC 230V/50Hz Phase: NEUTRAL

Temperature: 24°C Humidity: 52%

Pressure(mbar): 1002 Date: 2016/01/11



No.	Frequency	Factor	Reading	Level	Limit	Margin	Detector
	(MHz)	(dB)	(dBuV)	(dBuV)	(dBuV)	(dB)	
1	0.1500	10.13	37.52	47.65	65.99	-18.34	QP
2	0.1500	10.13	26.46	36.59	55.99	-19.40	AVG
3	0.1980	10.13	34.22	44.35	63.69	-19.34	QP
4	0.1980	10.13	24.49	34.62	53.69	-19.07	AVG
5	0.5420	10.15	29.31	39.46	56.00	-16.54	QP
6	0.5420	10.15	23.29	33.44	46.00	-12.56	AVG
7	0.8860	10.17	25.99	36.16	56.00	-19.84	QP
8	0.8860	10.17	19.75	29.92	46.00	-16.08	AVG
9	1.3180	10.18	20.70	30.88	56.00	-25.12	QP
10	1.3180	10.18	5.99	16.17	46.00	-29.83	AVG
11	2.0980	10.18	24.66	34.84	56.00	-21.16	QP
12	2.0980	10.18	15.36	25.54	46.00	-20.46	AVG
13	2.8860	10.20	23.11	33.31	56.00	-22.69	QP
14	2.8860	10.20	11.93	22.13	46.00	-23.87	AVG

Note: Measurement Level = Reading Level + Correct Factor

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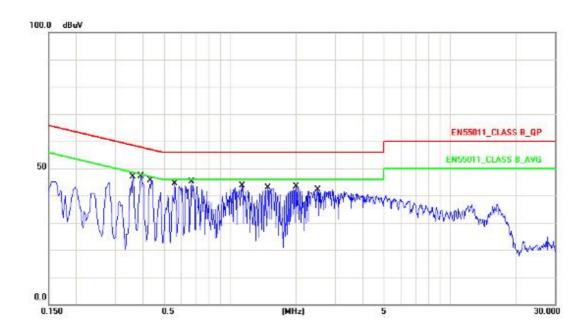


Report No.: SECM1601003 CE

Test Mode: Mode 2: Half Load

AC Power : AC 230V/50Hz Phase : LINE Temperature : 24°C Humidity : 52%

Pressure(mbar): 1002 Date: 2016/01/11



No.	Frequency (MHz)	Factor (dB)	Reading (dBuV)	Level (dBuV)	Limit (dBuV)	Margin (dB)	Detector
1	0.3620	10.15	35.15	45.30	58.68	-13.38	QP
2	0.3620	10.15	26.25	36.40	48.68	-12.28	AVG
3	0.3940	10.15	23.09	33.24	57.98	-24.74	QP
4	0.3940	10.15	10.54	20.69	47.98	-27.29	AVG
5	0.4340	10.15	22.99	33.14	57.18	-24.04	QP
6	0.4340	10.15	11.25	21.40	47.18	-25.78	AVG
7	0.5620	10.16	32.29	42.45	56.00	-13.55	QP
8	0.5620	10.16	23.39	33.55	46.00	-12.45	AVG
9	0.6700	10.15	13.60	23.75	56.00	-32.25	QP
10	0.6700	10.15	-0.36	9.79	46.00	-36.21	AVG
11	1.1380	10.16	5.80	15.96	56.00	-40.04	QP
12	1.1380	10.16	-1.33	8.83	46.00	-37.17	AVG
13	1.4940	10.16	18.86	29.02	56.00	-26.98	QP
14	1.4940	10.16	7.16	17.32	46.00	-28.68	AVG
15	2.0059	10.17	27.33	37.50	56.00	-18.50	QP
16	2.0059	10.17	16.05	26.22	46.00	-19.78	AVG
17	2.5059	10.18	23.95	34.13	56.00	-21.87	QP
18	2.5059	10.18	8.92	19.10	46.00	-26.90	AVG

Note: Measurement Level = Reading Level + Correct Factor

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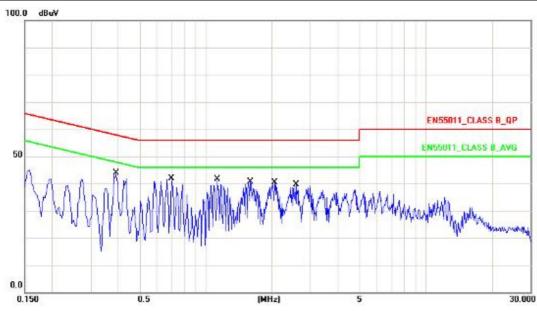


Test Mode: Mode 2: Half Load

AC Power: AC 230V/50Hz Phase: **NEUTRAL**

24°C Temperature: 52% Humidity:

Pressure(mbar): 1002 Date: 2016/01/11



No.	Frequency	Factor	Reading	Level	Limit	Margin	Detector
	(MHz)	(dB)	(dBuV)	(dBuV)	(dBuV)	(dB)	
1	0.3899	10.15	27.88	38.03	58.06	-20.03	QP
2	0.3899	10.15	20.17	30.32	48.06	-17.74	AVG
3	0.6980	10.16	16.28	26.44	56.00	-29.56	QP
4	0.6980	10.16	0.24	10.40	46.00	-35.60	AVG
5	1.1300	10.18	25.89	36.07	56.00	-19.93	QP
6	1.1300	10.18	17.46	27.64	46.00	-18.36	AVG
7	1.5940	10.18	11.93	22.11	56.00	-33.89	QP
8	1.5940	10.18	-0.78	9.40	46.00	-36.60	AVG
9	2.0579	10.18	8.05	18.23	56.00	-37.77	QP
10	2.0579	10.18	-0.81	9.37	46.00	-36.63	AVG
11	2.5820	10.19	20.61	30.80	56.00	-25.20	QP
12	2.5820	10.19	10.38	20.57	46.00	-25.43	AVG

Note: Measurement Level = Reading Level + Correct Factor

Test engineer:

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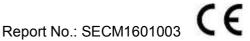


4.5.2 Conducted Emission for Telecommunication Port Test Data

Note: The EUT doesn't have the telecommunication port.

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4.6. Test Photographs of Power Port



Front View



Rear View

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5. Test of Radiated Emission

5.1. Test Limit

The EUT shall meet the limits of below Table when measured at the measuring distance R in accordance with the methods described in European Standard EN 55011 Clause 10. If the reading on the measuring receiver shows fluctuations close to the limit, the reading shall be observed for at least 15 s at each measurement frequency; the highest reading shall be recorded, with the exception of any brief isolated high reading, which shall be ignored.

Limits for radiated disturbances at a measuring distance of 10m (dB (µV/m))

Frequency range	Class A Equipment	Class B Equipment
(MHz)	Quasi-Peak	Quasi-Peak
30 – 230	40	30
230 – 1000	47	37

Remark:

- 1. The tighter limit shall apply at the edge between two frequency bands.
- 2. Distance refers to the distance in meters between the measuring instrument antenna and the closed point of any part of the device or system.

The EUT shall meet the limits of below Table when measured in accordance with the method described in European Standard EN 55022 Clause 10 and the conditional testing procedure described below.

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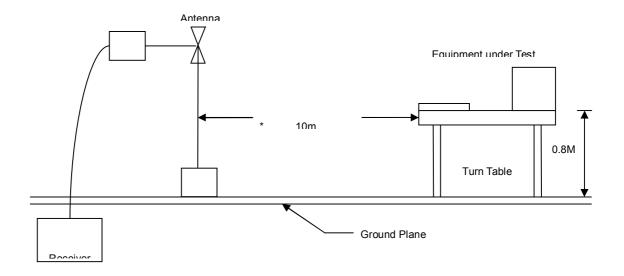


5.2. Test Procedures

- The EUT was placed on a rotatable table top 0.8 meter above ground. a.
- The EUT was set 3/10 meters from the interference receiving antenna which was mounted b. on the top of a variable height antenna tower.
- The table was rotated 360 degrees to determine the position of the highest radiation. C.
- The antenna is a half wave dipole and its height is varied between one meter and four meters above ground to find the maximum value of the field strength both horizontal polarization and vertical polarization of the antenna are set to make the measurement.
- e. For each suspected emission the EUT was arranged to its worst case and then tune the antenna tower (from 1 M to 4 M) and turn table (from 0 degree to 360 degrees) to find the maximum reading.
- Set the test-receiver system to Peak Detect Function and specified bandwidth with Maximum Hold Mode.
- If the emission level of the EUT in peak mode was 3 dB lower than the limit specified, then testing will be stopped and peak values of EUT will be reported, otherwise, the emissions which do not have 3 dB margin will be repeated one by one using the quasi-peak method and reported.

5.3. Typical Test Setup

Below 1GHz Test Setup



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5.4. Measurement Equipment

Instrument/Ancillary	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date.
EMI Test Receiver	R&S	ESCI7	100968	2015.03.29	2016.03.28
Preamplifier	Agilent	87405B	My39500554	2015.03.29	2016.03.28
Preamplifier	Agilent	8449B	3008A02342	2015.03.29	2016.03.28
Bilog Antenna	Sunol Science	JB1	A072414-1	2015.04.22	2016.04.21
Broad-Band Horn Antenna	Schwarzbeck	BBHA9120D	9120D-619	2015.04.20	2016.04.19
Spectrum Analyzer	R&S	FSP40	100324	2015.03.29	2016.03.28
Temperature/ Humidity Meter	Zhicheng	ZC1-11	CEP-TH-001	2015.04.02	2016.04.01
EZ-EMC	Fala	Ver CT3A1	N/A	N/A	N/A

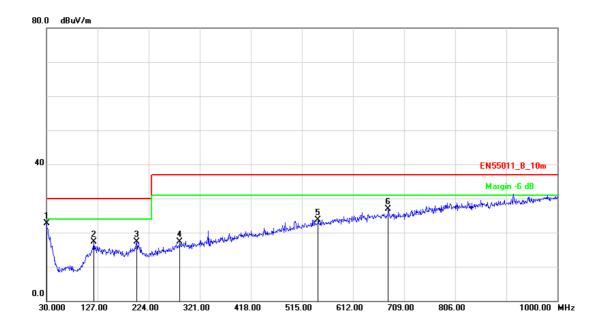
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Report No.: SECM1601003 **(€**

5.5. Test Result and Data (30MHz ~ 1GHz)

Test Mode :	Mode 1: Full Load		
AC Power :	AC 230V/50Hz	Ant. Polarization:	Horizontal
Temp :	24°C	Humidity:	52%
Pressure(mbar):	1002	Date :	2016/01/11



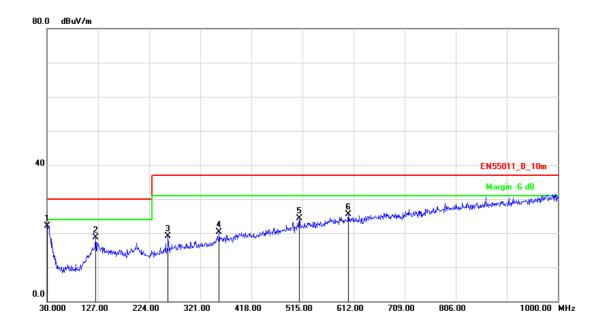
No.	Frequency	Factor	Reading	Level	Limit	Margin	Det.	Height	Azimuth
	(MHz)	(dB/m)	(dBuV)	(dBuV/m)	(dBuV/m)	(dB)		(cm)	(deg)
1	30.0000	-3.26	25.94	22.68	30.00	-7.32	peak	400	29
2	120.2099	-9.56	26.89	17.33	30.00	-12.67	peak	100	319
3	201.6899	-10.09	27.38	17.29	30.00	-12.71	peak	400	52
4	283.1700	-8.82	26.18	17.36	37.00	-19.64	peak	400	68
5	546.0399	-2.11	25.81	23.70	37.00	-13.30	peak	400	290
6	678.9299	-0.14	27.00	26.86	37.00	-10.14	peak	400	239

Note: Measurement Level = Reading Level + Correct Factor

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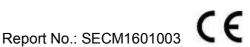
Test Mode :	Mode 1: Full Load		
AC Power :	AC 230V/50Hz	Ant. Polarization:	Vertical
Temp :	24°C	Humidity:	52%
Pressure(mbar):	1002	Date :	2016/01/11



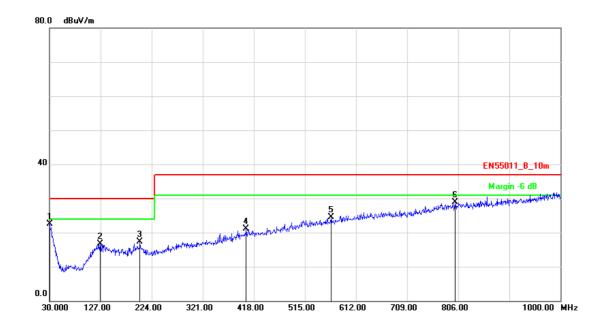
No.	Frequency	Factor	Reading	Level	Limit	Margin	Det.	Height	Azimuth
	(MHz)	(dB/m)	(dBuV)	(dBuV/m)	(dBuV/m)	(dB)		(cm)	(deg)
1	30.0000	-3.26	25.39	22.13	30.00	-7.87	peak	400	143
2	122.1500	-9.64	28.44	18.80	30.00	-11.20	peak	100	246
3	259.8900	-10.04	29.07	19.03	37.00	-17.97	peak	100	44
4	356.8900	-6.98	27.26	20.28	37.00	-16.72	peak	400	108
5	509.1800	-2.83	27.16	24.33	37.00	-12.67	peak	400	63
6	602.3000	-1.21	26.65	25.44	37.00	-11.56	peak	100	257

Note: Measurement Level = Reading Level + Correct Factor

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Test Mode :	Mode 2: Half Load		
AC Power :	AC 230V/50Hz	Ant. Polarization:	Horizontal
Temp :	24°C	Humidity:	52%
Pressure(mbar):	1002	Date :	2016/01/11



No.	Frequency	Factor	Reading	Level	Limit	Margin	Det.	Height	Azimuth
	(MHz)	(dB/m)	(dBuV)	(dBuV/m)	(dBuV/m)	(dB)		(cm)	(deg)
1	30.0000	-3.26	25.85	22.59	30.00	-7.41	peak	300	165
2	126.0300	-9.81	26.53	16.72	30.00	-13.28	peak	100	359
3	201.6899	-10.09	27.32	17.23	30.00	-12.77	peak	300	337
4	403.4499	-5.26	26.31	21.05	37.00	-15.95	peak	300	296
5	564.4699	-1.79	26.21	24.42	37.00	-12.58	peak	199	93
6	800.1799	2.07	26.82	28.89	37.00	-8.11	peak	400	122

Note: Measurement Level = Reading Level + Correct Factor

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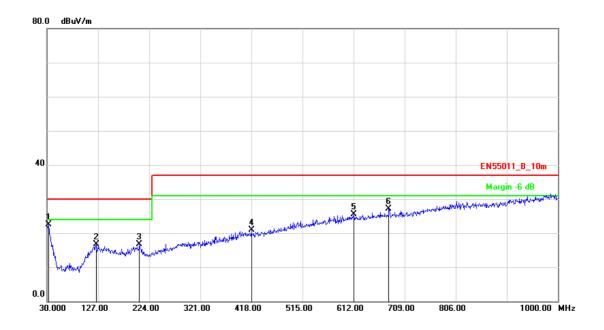
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Test Mode :	Mode 2: Half Load		
AC Power :	AC 230V/50Hz	Ant. Polarization:	Vertical
Temp :	24°C	Humidity:	52%
Pressure(mbar) :	1002	Date :	2016/01/11



No.	Frequency	Factor	Reading	Level	Limit	Margin	Det.	Height	Azimuth
	(MHz)	(dB/m)	(dBuV)	(dBuV/m)	(dBuV/m)	(dB)		(cm)	(deg)
1	32.9100	-5.36	27.88	22.52	30.00	-7.48	peak	300	323
2	123.1200	-9.69	26.34	16.65	30.00	-13.35	peak	100	179
3	205.5700	-10.48	27.28	16.80	30.00	-13.20	peak	100	353
4	418.0000	-5.26	26.13	20.87	37.00	-16.13	peak	400	52
5	612.9699	-1.07	26.50	25.43	37.00	-11.57	peak	400	238
6	678.9300	-0.14	27.28	27.14	37.00	-9.86	peak	400	233

Note: Measurement Level = Reading Level + Correct Factor

Test engineer:

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5.6. Test Photographs (30MHz~1GHz)



Front View



Rear View

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6. Harmonics Test

6.1. Limits of Harmonics Current Measurement

Limits for Class A equipment

Harmonics Order n	Max. permissible harmonics current A	Harmonics Order n	Max. permissible harmonics current A
Odd h	armonics	Even h	narmonics
3	2.30	2	1.08
5	1.14	4	0.43
7	0.77	6	0.30
9	0.40	8<=n<=40	0.23x8/n
11	0.33		
13	0.21		
15<=n<=39	0.15x15/n		

(b) Limits for Class B equipment

For Class B equipment, the harmonics of the input current shall not exceed the values given in Table that is the limit of Class A multiplied by a factor of 1,5.

(c) Limits for Class C equipment

()	
Harmonics Order n	Maximum permissible harmonic current expressed as a percentage of the input current at the fundamental frequency %
2	2
3	30 · λ [*]
5	10
7	7
9	5
11 <n<39 (odd harmonics only)</n<39 	3
* λ is the circuit power factor	

(d) Limits for Class D equipment

1 1				
Harmonics Order	Maximum permissible	Maximum permissible		
n	harmonic current per watt	harmonic current		
	mA/W	A		
3	3.4	2.30		
5	1.9	1.14		
7	1.0	0.77		
9	0.5	0.40		
11	0.35	0.33		
11 < n < 39	3.85/n	See limit of Class A		

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Report No.: SECM1601003

(odd harmonics only)	

NOTE: According to section 7 of EN 61000-3-2, the above limits for all equipment except for lighting equipment having an active input power > 75 W and no limits apply for equipment with an active input power up to and including 75 W.

6.2. Measurement Equipment

Instrument/Ancillary	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date.
EMC Emission Tester	EMCPARTNE R	Harmonics-1000	159	2015.04.24	2016.04.23
Temperature/ Humidity Meter	Zhicheng	ZC1-11	CEP-TH-004	2015.04.02	2016.04.01
HARCS	EMC Partner	Ver 4.18	N/A	N/A	N/A
ПАКСЗ	AG	Vei 4.16	IN/A	IN/A	IN/A

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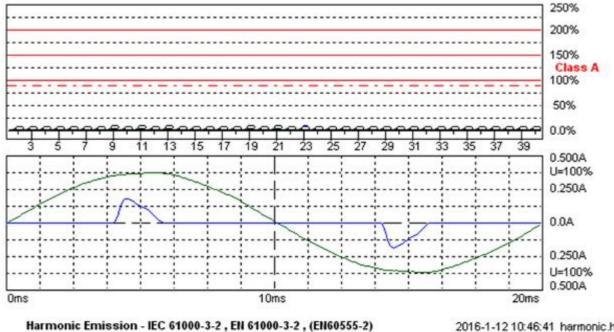
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6.1. Test Result and Data

Basic Standard	:	EN 61000-3-2
Final Test Result	:	PASS
Test Mode	:	Mode 1, Mode 2
Temperature	:	22 ℃
Humidity	:	50 %
Atmospheric Pressure	:	100 kPa
Test Date	:	Jan 12, 2016



2016-1-12 10:46:41 harmonic.hsu

Range: 6.148 W 0.044 Urms = THC = V-nom: 0.051 0.526 Irms = pf = TestTime:

Test completed, Result: PASSED

HAR-1000 EMC-Parter

15 min (100%)

0.5 A

230 V

Full Bar : Actual Values **Empty Bar: Maximum Values**

Blue: Current, Green: Voltage, Red: Failed

Urms = 230.1V Freq = 50.000 Range: 0.5 A Irms = 0.051A lpk = 0.190A cf 3.750 6.148W S = 11.69VA pf 0.526

THDi = 85.0 % THDu = 1.20 % Class A

Test - Time: 15min (100%)Test completed, Result: PASSED

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CERPASS TECHNOLOGY CORP.



Order 1	Freq. [Hz] 50	Irms [A] 0.0272	Irms%L [%]	Imax [A] 0.0295	lmax%L [%]	Limit [A]
2	100	0.0272	0.0396	0.0295	0.1385	1.0800
3	150	0.0248	1.0787	0.0270	1.1729	2.3000
4	200	0.0006	0.1490	0.0014	0.3265	0.4300
5	250	0.0219	1.9167	0.0237	2.0773	1.1400
6	300	0.0009	0.2950	0.0011	0.3560	0.3000
7	350	0.0183	2.3780	0.0201	2.6079	0.7700
8	400	0.0009	0.3715	0.0010	0.4246	0.2300
9	450	0.0141	3.5248	0.0163	4.0817	0.4000
10	500	0.0009	0.4644	0.0010	0.5307	0.1840
11	550	0.0099	3.0055	0.0128	3.8656	0.3300
12	600	0.0006	0.4180	0.0008	0.4976	0.1533
13	650	0.0065	3.0954	0.0097	4.6358	0.2100
14	700	0.0005	0.3483	0.0006	0.4876	0.1314
15	750	0.0046	3.0721	0.0076	5.0659	0.1500
16	800	0.0003	0.2388	0.0007	0.5838	0.1150
17 18	850	0.0045	3.3664	0.0062	4.6577	0.1324
19	900 950	0.0003 0.0049	0.2985 4.0975	0.0008 0.0062	0.7762 5.2056	0.1022 0.1184
20	1000	0.0049	0.3981	0.0002	0.8956	0.1104
21	1050	0.0004	4.5573	0.0065	6.0384	0.0920
22	1100	0.0043	0.5108	0.0009	1.0217	0.0836
23	1150	0.0004	4.4610	0.0060	6.0832	0.0030
24	1200	0.0004	0.5175	0.0009	1.1544	0.0767
25	1250	0.0034	3.8317	0.0049	5.4593	0.0900
26	1300	0.0003	0.4312	0.0009	1.2506	0.0708
27	1350	0.0025	2.9663	0.0039	4.6509	0.0833
28	1400	0.0002	0.3715	0.0009	1.3468	0.0657
29	1450	0.0019	2.4387	0.0033	4.2480	0.0776
30	1500	0.0002	0.3981	0.0009	1.4927	0.0613
31	1550	0.0019	2.6069	0.0033	4.5831	0.0726
32	1600	0.0003	0.5838	0.0009	1.5391	0.0575
33	1650	0.0021	3.0436	0.0035	5.1025	0.0682
34	1700	0.0004	0.7895	0.0009	1.5790	0.0541
35	1750	0.0021	3.2281	0.0034	5.3168	0.0643
36	1800	0.0005	0.8956	0.0008	1.6121	0.0511
37	1850	0.0019	3.0613	0.0031	5.0686	0.0608
38	1900	0.0004	0.8824	0.0008	1.6387	0.0484
39	1950	0.0015	2.6449	0.0027	4.6021	0.0577
40	2000	0.0003	0.7298	0.0008	1.6586	0.0460

EUT is PASSED if:

- all Average values of the Individual Harmonic Currents (lavg) are below 100% of the Individual Limits.
- all Maximum values of the Individual Harmonic Currents (Imax) are below 150% of the Individual Limits.

Test engineer:

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6.2. Test Photographs



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7. Voltage Fluctuations Test

7.1. Test Procedure

The equipment shall be tested under the conditions of Clause 5.

The total impedance of the test circuit, excluding the appliance under test, but including the internal impedance of the supply source, shall be equal to the reference impedance.

The stability and tolerance of the reference impedance shall be adequate to ensure that the overall accuracy of $\pm 8\%$ is achieved during the whole assessment procedure.

7.2. Measurement Equipment

Instrument/Ancillary	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date.
EMC Emission Tester	EMCPARTNE R	Harmonics-1000	159	2015.04.24	2016.04.23
Temperature/ Humidity Meter	Zhicheng	ZC1-11	CEP-TH-004	2015.04.02	2016.04.01
HARCS	EMC Partner	Ver 4.18	N/A	N/A	N/A
ПАКСЗ	AG	VEI 4.10	IN/A	IN/A	IN/A

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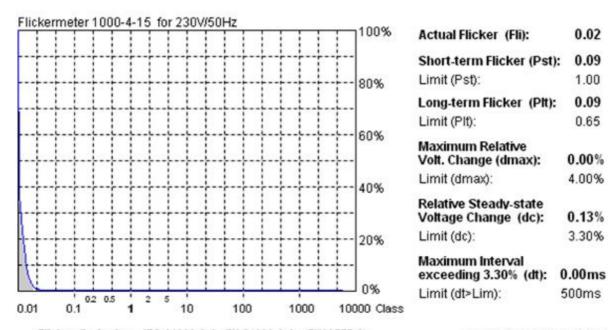
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7.3. Test Result and Data

Basic Standard	:	EN 61000-3-2
Final Test Result	:	PASS
Test Mode	:	Mode 1, Mode 2
Temperature	:	22 ℃
Humidity	:	50 %
Atmospheric Pressure	:	100 kPa
Test Date	:	Jan 12, 2016



Flicker Emission - IEC 61000-3-3, EN 61000-3-3, (EN60555-3)

6.050 W Urms = 230.1 V P = Irms = 0.050 A 0.528

Test completed, Result: PASSED

2016-1-12 10:58:40 harmonic.hsu

0.5 A Range: V-nom: 230 V TestTime:

10 min (100%)

HAR-1000 EMC-Partier

Full Bar : Actual Values **Empty Bar: Maximum Values** : Average Values

Blue: Current, Green: Voltage, Red: Failed

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Report No.: SECM1601003 **(€**

Urms = 230.1V Freq = 50.013 Range: 0.5 A Irms = 0.050A Ipk = 0.183A cf = 3.676 P = 6.050W S = 11.46VA pf = 0.528

Test - Time : 1 x 10min = 10min (100 %)

LIN (Line Impedance Network): No LIN

Limits: Plt: 0.65 Pst: 1.00

dmax: 4.00 % dc : 3.30 % dtLim: 3.30 % dt>Lim: 500ms

Test completed, Result: PASSED

Test engineer:

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7.4. Test Photographs



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8. Electrostatic Discharge Immunity Test

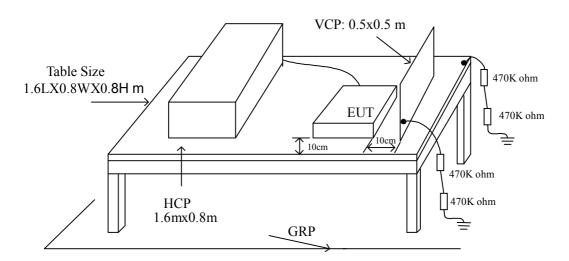
8.1. Test Procedure

- a. In the case of air discharge testing the climatic conditions shall be within the following ranges:
 - ambient temperature: 15[°]C to 35[°]C;
 - relative humidity: 30% to 60%;
 - atmospheric pressure: 86 KPa (860 mbar) to 106 KPa (1060 mbar).
- b. Test programs and software shall be chosen so as to exercise all normal modes of operation of the EUT. The use of special exercising software is encouraged, but permitted only where it can be shown that the EUT is being comprehensively exercised.
- c. The test voltage shall be increased from the minimum to the selected test severity level, in order to determine any threshold of failure. The final severity level should not exceed the product specification value in order to avoid damage to the equipment.
- d. The test shall be performed with both air discharge and contact discharge. On reselected points at least 10 single discharges (in the most sensitive polarity) shall be applied on air discharge. On reselected points at least 25 single discharges (in the most sensitive polarity) shall be applied on contact discharge.
- e. For the time interval between successive single discharges an initial value of one second is recommended. Longer intervals may be necessary to determine whether a system failure has occurred.
- f. In the case of contact discharges, the tip of the discharge electrode shall touch the EUT before the discharge switch is operated.
- g. In the case of painted surface covering a conducting substrate, the following procedure shall be adopted:
 - If the coating is not declared to be an insulating coating by the equipment manufacturer, then the pointed tip of the generator shall penetrate the coating so as to make contact with the conducting substrate.
 - Coating declared as insulating by the manufacturer shall only be submitted to the air discharge.
 - The contact discharge test shall not be applied to such surfaces.
- h. In the case of air discharges, the round discharge tip of the discharge electrode shall be approached as fast as possible (without causing mechanical damage) to touch the EUT. After each discharge, the ESD generator (discharge electrode) shall be removed from the EUT. The generator is then retriggered for a new single discharge. This procedure shall be repeated until the discharges are completed. In the case of an air discharge test, the discharge switch, which is used for contact discharge, shall be closed.

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8.2. Test Setup for Tests Performed in Laboratory



The test setup consists of the test generator, EUT and auxiliary instrumentation necessary to perform DIRECT and INDIRECT application of discharges to the EUT as applicable, in the follow manner:

- a. Contact Discharge to the conductive surfaces and to coupling plane;
- b. Air Discharge at insulating surfaces.

The preferred test method is that of type tests performed in laboratories and the only accepted method of demonstrating conformance with this standard. The EUT was arranged as closely as possible to arrangement in final installed conditions.

A ground reference plane was provided on the floor of the test site. It was a metallic sheet (copper or aluminum) of 0.25 mm, minimum thickness; other metallic may be used but they shall have at least 0.65 mm thickness. In the Cerpass Technology Corp., we provided 1 mm thickness stainless steel ground reference plane. The minimum size of the ground reference plane is $2.5 \text{ m} \times 2.5 \text{ m}$, the exact size depending on the dimensions of the EUT. It was connected to the protective grounding system.

The EUT was arranged and connected according to its functional requirements. A distance of 1m minimum was provided between the EUT and the wall of the lab. and any other metallic structure. In cases where this length exceeds the length necessary to apply the discharges to the selected points, the excess length shall, where possible, be placed non-inductively off the ground reference plane and shall not come closer than 0.2m to other conductive parts in the test setup.

Where the EUT is installed on a metal table, the table was connected to the reference plane via a cable with a 470k ohm resister located at each end, to prevent a build-up of charge. The test setup was consist a wooden table, 0.8m high, standing on the ground reference plane. A HCP, 1.6 m \times 0.8 m, was placed on the table. The EUT and cables was isolated from the HCP by an insulating support 0.5 mm thick. The VCP size, 0.5 m \times 0.5 m.

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8.3. Test Severity Levels

	Contact Discharge	Air Discharge				
Level	Test Voltage (KV) of	Level Test Voltage (KV) o				
	Contact discharge		Air Discharge			
1	±2	1	<u>±2</u>			
2	± 4	2	<u>±</u> 4			
3	±6	3	±8			
4	±8	4	±15			
Х	Specified	X Specified				
Remark: "X" is an open level.						

8.4. Measurement Equipment

Instrument/Ancillary	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date.	
ESD Simulator	EM Test	dito	V0714102399	2015.04.28	2016.04.27	
Tonometer	shanghaifengyun	DYM3	3251	2015.12.01	2016.11.30	
Dehumidifier	ZEDO	ZD-220LB	CEP-TH-01	N/A	N/A	
Humidifier	YADU	YZ-DS251C	CEP-TH-02	N/A	N/A	
Temperature/	feiyan	N/A	102	2015.04.02	2016.04.01	
Humidity Meter	leiyali	IN/A	102	2013.04.02	2010.04.01	

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8.5. Test Result and Data

Final Test Result : PASS

Pass performance criteria : A Required performance criteria : B

Basic Standard : IEC 61000-4-2 Product Standard : EN 60601-1-2

Test Voltage $\begin{array}{ccc} & \pm 2 \ / \ \pm 4 \ / \ \pm 8 \ \text{KV for air discharge}, \\ & \pm 2 \ / \ \pm 4 \ / \ \pm 6 \ \text{KV for contact discharge} \end{array}$

Temperature : 26°C
Relative Humidity : 48 %
Atmospheric Pressure : 1011 hPa
Test Date : Jan.12, 2016

		Contact Discharge				Air Discharge										
		times / each					10 times / each									
Voltage	2	2 kV 4 kV 6 kV 8 kV			2 kV 4 kV			kV	8 kV		15kV					
Point\Polarity	+	_	+	_	+	_	+	_	+	_	+	_	+		+	_
HCP	Α	Α	Α	Α	Α	Α	Α	Α								
VCP	Α	Α	Α	Α	Α	Α	Α	Α								
Case									Α	Α	Α	Α	Α	Α	Α	Α
Power Port									Α	Α	Α	Α	Α	Α	Α	Α
USB Port									Α	Α	Α	Α	Α	Α	Α	Α

Note:" A" means the EUT function is normal working during the test.

Test engineer:

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8.6. Test Photographs



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9. Radio Frequency electromagnetic field immunity test

9.1. Test Procedure

- a. The equipment to be tested is placed in the center of the enclosure on a wooden table. The equipment is then connected to power and signal leads according to pertinent installation instructions.
- b. The antenna which is enabling the complete frequency range of 80~2,500 MHz is placed 3m away from the equipment. The required field strength is determined by placing the field strength meter(s) on top of or directly alongside the equipment under test and monitoring the field strength meter via a remote field strength indicator outside the enclosure while adjusting the continuous-wave to the applicable antennae.
- c. The test is normally performed with the antenna facing the most sensitive side of the EUT. The polarization of the field generated by the bucolical antenna necessitates testing each position twice, once with the antenna positioned vertically and again with the antenna positioned horizontally. The circular polarization of the field from the log-spiral antenna makes a change of position of the antenna unnecessary.
- d. At each of the above conditions, the frequency range is swept 80~2,500 MHz, pausing to adjust the R.F. signal level or to switch oscillators and antenna. The rate of sweep is in the order of 1.5*10-3 decades/s. The sensitive frequencies or frequencies of dominant interest may be discretely analyzed.

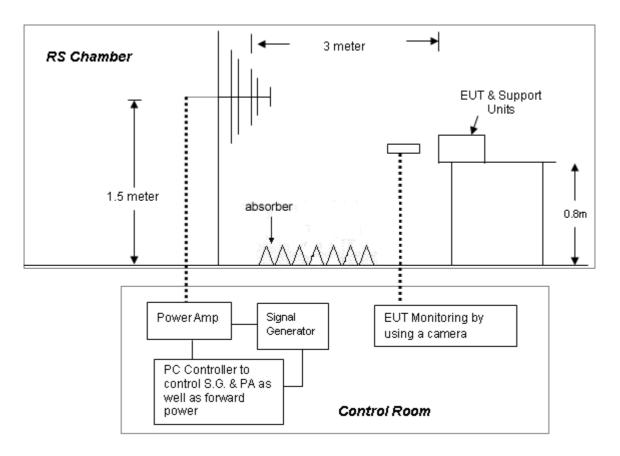
9.2. Test Severity Levels

Frequency Band: 80~2,500 MHz					
Level	Test field strength (V/m)				
1	1				
2	3				
3	10				
X	Specified				
Remark:	"X" is an open class.				

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9.3. TEST SETUP



 For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

NOTE:

TABLETOP EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

FLOOR STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

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9.4. Measurement Equipment

Instrument/Ancillary	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date.
Signal Generator	R&S	SML03	103287	2015.03.29	2016.03.28
Power Sensor	R&S	NR P-Z91	100383	2015.03.29	2016.03.28
Power Sensor	R&S	NRP-Z91	100384	2015.03.29	2016.03.28
Power Meter	R&S	NRP	101206	2015.03.29	2016.03.28
Power Amplifer	BONN	BLWA0830-16 0/100/40D	076659	2015.03.29	2016.03.28
Istropic Electric Field Probe	EST.LINDGRE N	HI-6105	137445	2015.11.20	2016.11.19
EMS Antenna	R&S	HL046E	100028	N/A	N/A
Temperature/ Humidity Meter	feiyan	N/A	101	2015.04.02	2016.04.01
EMC-32	Rohde&Schwa rz	Ver 6.10.0	N/A	N/A	N/A

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9.5. Test Result and Data

Final Test Result : PASS

Pass performance criteria : A Required performance criteria: A

Basic Standard : IEC 61000-4-3 **Product Standard** : EN 60601-1-2 Frequency Range : 80~2,500 MHz

Temperature : 25°C **Relative Humidity** : 49 % Atmospheric Pressure : 1010 hPa **Test Date** : Jan.12, 2016

Modulation : AM 80% , 1KHz sine wave, Dwell time: 3S Frequency Step Size : 1 % of preceding frequency value							
Frequency (MHz) Antenna Polarization Face Field strength (V/m) Resi							
80~2500	Vertical	Front	3 V/m	Α			
80~2500	Vertical	Rear	3 V/m	Α			
80~2500	Vertical	Left	3 V/m	Α			
80~2500	Vertical	Right	3 V/m	Α			
80~2500	Horizontal	Front	3 V/m	Α			
80~2500	Horizontal	Rear	3 V/m	Α			
80~2500	Horizontal	Left	3 V/m	А			
80~2500	Horizontal	Right	3 V/m	Α			

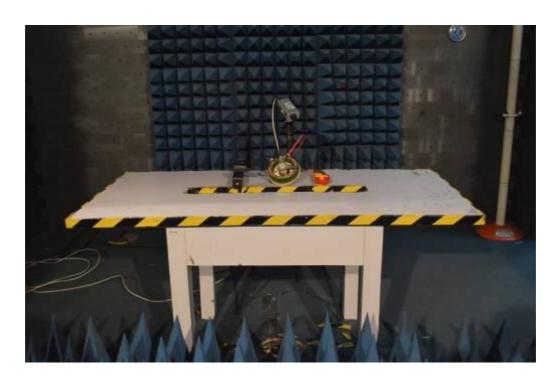
Note: "A" means the EUT function is normal working during the test.

Seller Test engineer: ___

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9.6. Test Photographs



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10. Electrical Fast Transient/ Burst Immunity Test

10.1. Test Procedure

- a. In order to minimize the effect of environmental parameters on test results, the climatic conditions when test is carrying out shall comply with the following requirements:
 - ambient temperature: 15[°]C to 35[°]C;
 - relative humidity: 45% to 75%;
 - Atmospheric pressure: 86 Kpa (860 mbar) to 106 Kpa (1060 mbar).
- b. In order to minimize the effect of environmental parameters on test results, the electromagnetic environment of the laboratory shall not influence the test results.
- c. The variety and diversity of equipment and systems to be tested make it difficult to establish general criteria for the evaluation of the effects of fast transients/bursts on equipment and systems.
- d. Test on Power Line:
 - The EFT/B-generator was located on the GRP.
 For floor standing equipment 1,0 m
 For table top equipment 0,5 m
 - The EFT/B-generator provides the ability to apply the test voltage in a non-symmetrical condition to the power supply input terminals of the EUT.
- e. Test on Communication Lines
 - The coupling clamp is composed of a clamp unit for housing the cable (length more than 3 m), and was placed on the GRP.
 - The coupling clamp provides the ability of coupling the fast transient/bursts to the cable under test.
- f. The test results may be classified on the basic of the operating conditions and the functional specification of the equipment under test, according to the following performance criteria:
 - Normal performance within the specification limits.
 - Temporary degradation or loss of function or performance which is self-recoverable.
 - Temporary degradation or loss of function or performance which requires operator intervention or system reset.
 - Degradation or loss of function which is not recoverable due to damage of equipment (components).

10.2. Test Severity Levels

The following test severity levels are recommended for the fast transient/burst test:

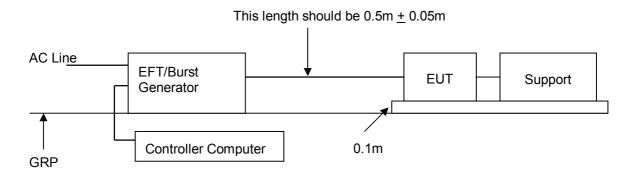
Open circuit output test voltage ± 10%							
Level	On Power Supply	On I/O signal, data and control line					
1	0.5 KV	0.25 KV					
2	1.0 KV	0.50 KV					
3	2.0 KV	1.00 KV					
4	4.0 KV	2.00 KV					
X	Specified	Specified					

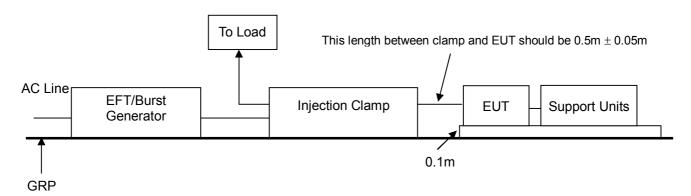
Remark: "X" is an open level. The level is subject to negotiation between the user and manufacturer or is specified by the manufacturer.

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10.3. TEST SETUP





For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

NOTE:

TABLETOP EQUIPMENT

The configuration consisted of a wooden table (0.1m high) standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system. A minimum distance of 0.5m was provided between the EUT and the walls of the laboratory or any other metallic structure.

FLOOR STANDING EQUIPMENT

The EUT installed in a representative system as described in section 7 of IEC 61000-4-4 and its cables, were isolated from the Ground Reference Plane by an insulating support that is 0.1-meter thick. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system.

10.4. Measurement Equipment

Instrument/Ancillary	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date.
TRANSIENT	EMCPARTNER	TRA2000IN6	901	2015.03.29	2016.03.28
CDN	EMCPARTNER	CDN2000-06-32	121	2015.03.29	2016.03.28
Coupling clamp	EMCPARTNER	CN-EFT1000	547	2015.03.29	2016.03.28
Temperature/ Humidity Meter	Zhicheng	ZC1-11	CEP-TH-005	2015.04.02	2016.04.01

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10.5. Test Result and Data

Final Test Result **PASS**

Pass performance criteria В Required performance criteria: В

Basic Standard IEC 61000-4-4 **Product Standard** EN 60601-1-2

On Power Supply -- ± 0.5 KV, ± 1.0 KV, ± 2.0 KV Test Voltage

On Signal Port -- ±0.5 KV, ±1.0 KV

Temperature 25°C **Relative Humidity** : 49 % Atmospheric Pressure : 1010 hPa **Test Date** : Jan.12, 2016

Pulse : 5/50 ns						
Burst : 15m/300r	Repetition Rate: 5 kHz					
Test time : 1 min/each condition						
Voltage / Mada / Dalagity / Daggitt / Dhaga		_1.0) kV	2.0 kV		
Voltage/ Mode/ P	Voltage/ Mode/ Polarity/ Result/ Phase		_	+	_	
	L			Α	Α	
Power Line	N			Α	Α	
	L-N			Α	Α	

Note: "A" Means the EUT function is normal working during the test.

Test engineer: __

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10.6. Test Photographs



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11. Surge Immunity Test

11.1. Test Procedure

Climatic conditions

The climatic conditions shall comply with the following requirements:

- ambient temperature : 15 °C to 35 °C
- relative humidity: 10 % to 75 %
- atmospheric pressure: 86 kPa to 106 kPa (860 mbar to 1060 mbar)
- b. Electromagnetic conditions

the electromagnetic environment of the laboratory shall not influence the test results.

- The test shall be performed according the test plan that shall specify the test set-up with
 - generator and other equipment utilized;
 - test level (voltage/current);
 - generator source impedance;
 - internal or external generator trigger;
 - number of tests: at least five positive and five negative at the selected points;
 - repetition rate: maximum 1/min.
 - inputs and outputs to be tested;
 - · representative operating conditions of the EUT;
 - sequence of application of the surge to the circuit;
 - phase angle in the case of AC. power supply;
 - actual installation conditions, for example :
 - AC: neutral earthed,
 - DC: (+) or (-) earthed to simulated the actual earthing conditions.
- If not otherwise specified the surges have to be applied synchronized to the voltage phase at the zero-crossing and the peak value of the AC. voltage wave (positive and negative).
- The surges have to be applied line to line and line(s) and earth. When testing line to earth, e. the test voltage has to be applied successively between each of the lines and earth, if there is no other specification.
- f. The test procedure shall also consider the non-linear current-voltage characteristics of the equipment under test. Therefore the test voltage has to be increased by steps up to the test level specified in the product standard or test plan.
- All lower levels including the selected test level shall be satisfied. For testing the secondary protection, the output voltage of the generator shall be increased up to the worst-case voltage breakdown level (let-through level) of the primary protection.
- If the actual operating signal sources are not available, that may be simulated. Under no circumstances may the test level exceed the product specification. The test shall be carried out according to a test plan.
- To find all critical points of the duty cycle of the equipment, a sufficient number of positive and negative test pulses shall be applied. For acceptance test previously unstressed equipment shall be used to the protection devices shall be replaced.

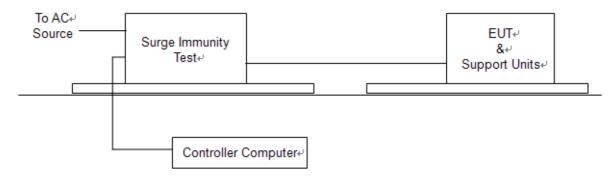
11.2. Test Severity Level

Level	Level Open-circuit test voltage, ± 10%, KV						
1	0.5						
2	1.0						
3	2.0						
4	4.0						
X	Specified						
NOTE: "X" is an open class. This level can be specified in the product specification.							

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11.3. TEST SETUP

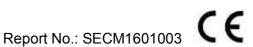


For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

11.4. Measurement Equipment

Instrument/Ancillary	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date.	
TRANSIENT	EMCPARTNER	TRA2000IN6	901	2015.03.29	2016.03.28	
CDN	EMCPARTNER	CDN-UTP8	021	2015.03.29	2016.03.28	
CDN	EMCPARTNER	CDN2000-06-32	121	2015.03.29	2016.03.28	
Temperature/	Zhicheng	ZC1-11	CEP-TH-005	2015.04.02	2016.04.01	
Humidity Meter	=::::::::		3 = 1 1 1 0 0 0			

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11.5. Test Result and Data

Final Test Result : PASS

Pass performance criteria : A Required performance criteria : B

Basic Standard : IEC 61000-4-5 **Product Standard** : EN 60601-1-2

Test Voltage : Input AC Power Port -- \pm 0.5 kV, \pm 1.0 kV, \pm 2.0 kV

Temperature : 25°C : 49 % Relative Humidity Atmospheric Pressure : 1010 hPa **Test Date** : Jan.12, 2016

Power Port

Waveform : 1.2/50µs(8/20µs)		petition	rate : 60 se	c Time : 2	Time: 20 time/each condition			
/Phase Voltage /	0°	90°	180°	270°				
<u>0.5/1.0</u> kV	L-N	+	Α	Α	Α	Α		
	L-IN	_	Α	Α	Α	Α		

Note:" A" means the EUT function is normal working during the test.

Test engineer:

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11.6. Test Photographs



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12. Conduction Disturbances induced by Radio-Frequency Fields

12.1. Test Procedure

- The EUT shall be operated within its intended climatic conditions. The temperature and relative humidity should be recorded.
- This test method test can be performed without using a sell shielded enclosure. This is b. because the disturbance levels applied and the geometry of the setups are not likely to radiated a high amount of energy, especially at the lower frequencies.

 If under certain circumstances the radiated energy is too high, a shielded enclosure has to be used.
- c. The test shall be performed with the test generator connected to each of the coupling and decoupling devices in turn while the other non-excited RF-input ports of the coupling devices are terminated by a 50 ohm load resistor.
- The frequency range is swept from 150 KHz to 80 MHz, using the signal levels established during the setting process, and with the disturbance signal 80% amplitude modulated with a 1KHz sign wave, pausing to adjust the RF-signal level or to switch coupling devices as necessary. The rate of sweep shall no exceed 1.5 x 10⁻³ decades/s. Where the frequency is swept incrementally, the step size shall no exceed 1% of the start and thereafter 1% of the preceding frequency value.
- The dwell time at each frequency shall not be less than the time necessary for the EUT to be exercised, and able to respond. Sensitive frequencies e.g. clock frequency (ies) and harmonics or frequencies of dominant interest shall be analyzed separately.
- An alternative test procedure may be adopted, wherein the frequency range is swept incrementally, with a step size not exceeding 4% of the start ad thereafter 4% of the preceding frequency value. The test level should be at least twice the value of the specified test level.
- In cases of dispute, the test procedure using a step size not exceeding 1% of the start and thereafter 1% of preceding frequency value shall take precedence.
- Attempts should be made to fully exercise the EUT during testing, and to fully interrogate all exercise modes selected for susceptibility.
- The use of special exercising programs is recommended.
- Testing shall be performed according to a Test Plan, which shall be included in the test report. j.
- It may be necessary to carry out some investigatory testing in order to establish some aspects of the test plan.

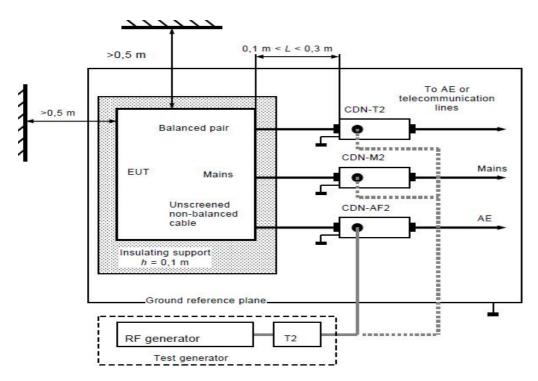
12.2.Test Severity Levels

Level	Voltage Level (e.m.f.)
1	1 V
2	3 V
3	10 V
Х	Specified
NOTE - x is an open cla	ass. This level can be specified in the product specification.

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12.3.TEST SETUP



Note: 1. The EUT is setup 0.1m above Ground Reference Plane

- 2. The CDNs and / or EM clamp used for real test depends on ports and cables configuration of EUT.
- 3. For the actual test configuration, please refer to the related item Photographs of the Test Configuration.

12.4.Measurement Equipment

Instrument/Ancillary	Manufacturer	Model No.	Serial No.	Calibration Date	Valid Date.	
Conducted immunity test system	FRANKONIA	CIT-10/75	102D1294	2015.03.29	2016.03.28	
EM Injection clamp	FCC	F-203I-23MM	536	2015.03.29	2016.03.28	
CDN	FRANKONIA	CDN-T2	A3010029	2015.03.29	2016.03.28	
CDN	FRANKONIA	CDN-T4	A3015017	2015.03.29	2016.03.28	
CDN	FRANKONIA	CDN-T8	A3022010	2015.03.29	2016.03.28	
CDN	FRANKONIA	CDN-M2	A3002037	2015.03.29	2016.03.28	
CDN	FRANKONIA	CDN-M2+M3	A3011102	2015.03.29	2016.03.28	
CDN	FCC	CDN-M5/32	A3013024	2015.03.29	2016.03.28	
6 dB Attenuator	FRANKONIA	N/A	N/A	2015.03.29	2016.03.28	
Temperature/	76: 06 0 0 0	704.44	CED TH OOF	2045 04 02	2010 04 04	
Humidity Meter	Zhicheng	ZC1-11	CEP-TH-005	2015.04.02	2016.04.01	
EN61000-4-6	Hubert GmbH	Ver 2.21	N/A	N/A	N/A	

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12.5. Test Result and Data

Final Test Result : PASS

Pass performance criteria : A Required performance criteria : A

Basic Standard : IEC 61000-4-6 Product Standard : EN 60601-1-2

Coupling mode : CDN-(M3) for AC power ports CDN-T400, Clamp for Signal Ports

Temperature : 25°C
Relative Humidity : 49 %
Atmospheric Pressure : 1010 hPa
Test Date : Jan.12, 2016

Frequency: 0.15~80MHz, Modulation: AM 80%,1KHz sine wave, Dwell time: 3s Frequency Step Size: 1 % of preceding frequency value								
Frequency Test Mode Voltage(V) Result								
0.15 ~ 80MHz Power(M2) 3 A								

Note: "A" Means the EUT function is normal working during the test.

Test engineer:

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12.6. Test Photographs

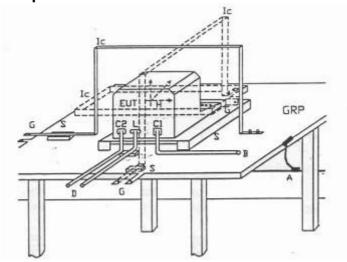


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13. Power Frequency Magnetic Field Immunity Test

13.1. Test Setup



GPR : Ground plane C1 : Power supply circuit

A : Safety earth C2 : Signal circuit

S : Insulating support L : Communication line
EUT : Equipment under test B : To power supply source
Lc : Induction coil D : To signal source, simulator

E : Earth terminal G : To the test generator

13.2. Test Severity Levels

Level	Magnetic field strength (A/m)
1	1
2	3
3	10
4	30
5	100
X ¹⁾	special
NOTE 1 "X" is an open	level. This level can be given in the product specification

13.3. Measurement Equipment

Instrument/Ancillary	Manufacturer Model No. Serial No.		Calibration Date	Valid Date.	
TRANSIENT	EMCPARTNER	NER TRA2000IN6 901		2015.03.29	2016.03.28
H-Filed-Loop	EMCPARTNER	MF1000-1	144	2015.03.29	2016.03.28
Temperature/ Humidity Meter	Zhicheng	ZC1-11	CEP-TH-005	2015.04.02	2016.04.01

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13.4. Test Result and Data

Final Test Result : PASS

Pass performance criteria : A Required performance criteria: A

Basic Standard : IEC 61000-4-8 Product Standard : EN 55024

Temperature : 25°C Relative Humidity : 49 % Atmospheric Pressure : 1010 hPa Test Date : Jan.12, 2016

Power Frequency Magnetic Field : 50/60 Hz, 3 A/m							
Coil Orientation Testing duration Results							
X-axis	Α						
Y-axis	1.0 Min	Α					
Z-axis	1.0 Min	А					

Note: "A" Mean the EUT function is normal working during the test.

Test engineer:

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13.5. Test Photographs





14. Voltage Dips and Voltage Interruptions Immunity Test Setup

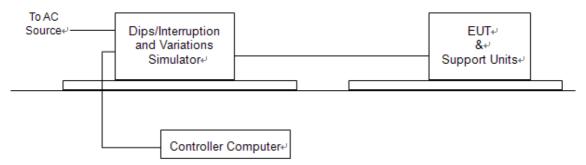
14.1. Test Conditions

- 1. Source voltage and frequency: 100 / 230 / 240V / 50Hz, Single phase.
- 2. Test of interval: 10 sec.
- 3. Level and duration: Sequence of 3 dips/interrupts.
- 4. Voltage rise (and fall) time: 1 \sim 5 $\mu s.$
- 5. Test severity:

Voltage dips (%)	Test Duration (period)
0%	0.5
60%	5
30%	25

Voltage Interrupt reduction (%)	Test Duration (period)
0%	250

14.1. TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

14.2. Measurement Equipment

Instrument/Ancillary	Manufacturer	Manufacturer Model No. Seria		Serial No. Calibration Date	
TRANSIENT	EMCPARTNER	TRA2000IN6	2000IN6 901		2016.03.28
Temperature/ Humidity Meter	Zhicheng	ZC1-11	CEP-TH-005	2015.04.02	2016.04.01

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14.3. Test Result and Data

Final Test Result : PASS

Pass performance Criteria : C for voltage interruption, A for voltage dips Required performance Criteria : C for voltage interruption, B/C for voltage dips

Basic Standard : IEC 61000-4-11 Product Standard : EN 60601-1-2

Temperature : 25°C
Relative Humidity : 49 %
Atmospheric Pressure : 1010 hPa
Test Date : Jan.12, 2016

Voltage(UT): AC 2	Voltage(UT): AC 230 V 50 Hz Interval(s): 10s Times: 3									
	Test level Durations Phase / Result									
Test mod	UT %	(period / ms)	0	45	90	135	180	225	270	315
Voltage interruptions	>95%	250	С	С	С	С	С	С	С	С
	30%	25	В	В	В	В	В	В	В	В
Voltage dips	60%	5	В	В	В	В	В	В	В	В
	>95%	0.5	В	В	В	В	В	В	В	В

Voltage(UT): AC 100 V 50 Hz Interval(s): 10s Times: 3										
	Test level	Durations		Phase / Result						
Test mod	UT %	(period / ms)	0	45	90	135	180	225	270	315
Voltage interruptions	>95%	250	С	С	С	С	С	С	С	С
	30%	25	В	В	В	В	В	В	В	В
Voltage dips	60%	5	В	В	В	В	В	В	В	В
	>95%	0.5	В	В	В	В	В	В	В	В

Note: "A" means the EUT function is normal working during the test.

"C" means the EUT function is affected during the test, and it can be recovered by manual resetting.

Test engineer:

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14.4. Test Photographs



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CE

15. Photographs of EUT

1) EUT Photo



2) EUT Photo



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3) EUT Photo



4) EUT Photo



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5) EUT Photo



6) EUT Photo



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7) EUT Photo



8) EUT Photo



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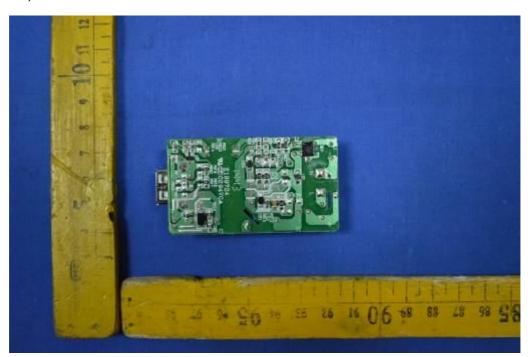




9) EUT Photo



10) EUT Photo



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